TL712 DIFFERENTIAL COMPARATOR

SLCS002C - JUNE 1983 - REVISED AUGUST 2000

8 🛛 V_{CC}

7 DUT-

6 OUT+

🛛 GND

5

NC-No internal connection

D, P, OR PS PACKAGE (TOP VIEW)

NC [

IN+ 🛛 3

OE

4

IN−**[**] 2

- Operates From a Single 5-V Supply
- 0 to 5.5 V Common-Mode Input Voltage Range
- Self-Biased Inputs
- Complementary 3-State Outputs
- Enable Capability
- Hysteresis . . . 5 mV Typ
- Response Times . . . 25 ns Typ

description

The TL712 is a high-speed comparator fabricated with bipolar Schottky process technology. The circuit has differential analog inputs and complementary 3-state TTL-compatible logic outputs with symmetrical switching characteristics. When the output enable (OE) is low, both outputs are in the high-impedance state. This device operates from a single 5-V supply and is useful as a disk memory read-chain data comparator.

The TL712C is characterized for operation from 0°C to 70°C.

AVAILABLE OPTIONS						
	PACKAGED DEVICES					
Τ _Α	PLASTIC SMALL OUTLINE (D)	PLASTIC SMALL-OUTLINE EIAJ (PS)	PLASTIC DIP (P)			
0°C to 70°C	TL712CD	TL712CPSR	TL712CP			

The PS package is only available tape and reeled. The D package also is available taped and reeled. Add the suffix R to device type (e.g., TL712CDR).

symbol (positive logic)



PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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schematics of inputs and outputs



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage, V _{CC} (see Note 1)	
Differential input voltage, V _{ID} (see Note 2)	±25 V
Input voltage, V _I , any differential input	±25 V
Output enable voltage	
Low-level output current, I _{OL}	50 mA
Package thermal impedance, θ _{JA} (see Note 3): D package	97°C/W
P package	85°C/W
PS package	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the "recommended operating conditions" section of this specification is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values, except differential voltages, are with respect to the network ground.
 - 2. Differential voltage values are at IN+ with respect to IN-.
 - 3. The package thermal impedance is calculated in accordance with JESD 51.



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recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}	4.75	5	5.25	V
Common-mode input voltage, VIC	0		5.5	V
High-level output current, I _{OH}			-1	mA
Low-level output current, I _{OL}			16	mA
Operating free-air temperature, T _A	0		70	°C

electrical characteristics at V_{CC} = 5 V, T_A = 25 $^{\circ}\text{C}$

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
VT	Threshold voltage (VT + and VT –)	$V_{ICR} = 0$ to 5 V		-100†		100	mV
V _{hys}	Hysteresis (V _{T+} – V _T _)				5		mV
∨он	High-level output voltage	V _{ID} = 100 mV, I _{OH}	= – 1 mA	2.7	3.5		V
VOL	Low-level output voltage	$V_{ID} = -100 \text{ mV}, \text{I}_{OL}$	= 16 mA		0.4	0.5	V
loz	Off-state output current	V _O = 2.4 V				-20	μΑ
Ц	Enable current	V _I = 5.5 V				100	μΑ
IIH	High-level enable current	V _{IH} = 2.7 V				20	μΑ
Ι _Ι	Low-level enable current	V _{IL} = 0.4 V				-360	μΑ
ri	Differential input resistance			4			kΩ
r _o	Output resistance					100	W
los	Short-circuit output current			-15		-85	mA
Icc	Supply current	V _{ID} = 0, No load			17	20	mA

[†] The algebraic convention, where the more negative limit is designated as minimum, is used in this data sheet for input threshold voltage levels only.

switching characteristics, V_{CC} = 5 V, T_A = 25 $^\circ C$

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
^t PLH	Propagation delay time, low-to-high-level output	TTL load,	I, See Figure 1,	See Note 4		25		ns
^t PHL	Propagation delay time, high-to-low-level output					25		ns

NOTE 4: The response time specified is for a 100-mV input step with 5-mV overdrive (105 mV total), and is the interval between the input step function and the instant when the output crosses 2.5 V.



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PARAMETER MEASUREMENT INFORMATION



NOTE A: All diodes are 1N4148 or equivalent.







Figure 3



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TYPICAL CHARACTERISTICS



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